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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
08/893,917	07/11/1997	KARL A. LITTAU	AM2119/T2130	8435
	7590 09/05/2007 D AND TOWNSEND AND CREW LLP / AMAT		EXAMINER	
TWO EMBARCADERO CENTER			ZERVIGON, RUDY	
EIGHTH FLOOR SAN FRANCISCO, CA 94111-3834		ART UNIT	PAPER NUMBER	
	,		1763	
			MAIL DATE	DELIVERY MODE
			09/05/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

٧.	Application No.	Applicant(s)				
	08/893,917	LITTAU ET AL.				
Office Action Summary	Examiner	Art Unit				
	Rudy Zervigon	1763				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DATE of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  If NO period for reply is specified above, the maximum statutory period value of the provision of the period for reply within the set or extended period for reply will, by statute any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from , cause the application to become ABANDONE	I. the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 28 Ju	<u>ine 2007</u> .					
2a) This action is <b>FINAL</b> . 2b) ⊠ This	This action is <b>FINAL</b> . 2b)⊠ This action is non-final.					
• •	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims		,				
4)⊠ Claim(s) <u>16-20,22-24,27 and 28</u> is/are pending in the application.						
• • • • • • • • • • • • • • • • • • • •	4a) Of the above claim(s) <u>16-20</u> is/are withdrawn from consideration.					
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>22-24,27 and 28</u> is/are rejected.	6)⊠ Claim(s) <u>22-24,27 and 28</u> is/are rejected.					
7) Claim(s) is/are objected to.	) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction and/o	r election requirement.					
Application Papers						
9) The specification is objected to by the Examine	r.					
10)⊠ The drawing(s) filed on <u>11 July 1997</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11)☐ The oath or declaration is objected to by the Ex	caminer. Note the attached Office	Action or form PTO-152.				
Priority under 35 U.S.C. § 119						
12)☐ Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a)	)-(d) or (f).				
a) ☐ All b) ☐ Some * c) ☐ None of:						
1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority document	s have been received in Applicati	on No				
3. Copies of the certified copies of the prior	rity documents have been receive	ed in this National Stage				
application from the International Bureau	, ,,					
* See the attached detailed Office action for a list	of the certified copies not receive	ed.				
Attachment(s)						
1) Notice of References Cited (PTO-892)	4) Interview Summary Paper No(s)/Mail Da					
Notice of Draftsperson's Patent Drawing Review (PTO-948)     Information Disclosure Statement(s) (PTO/SB/08)     Paper No(s)/Mail Date	5) Notice of Informal P					

# **DETAILED ACTION**

# Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on April 26, 2007 and June 28, 2007 is entered.

#### Election/Restrictions

2. This application contains claims 16-20 drawn to an invention nonelected with traverse in Paper No. March 3, 2006. A complete reply to the final rejection must include cancellation of nonelected claims or other appropriate action (37 CFR 1.144) See MPEP § 821.01.

# Claim Rejections - 35 USC § 102

- 3. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.
- 4. Claims 22-24, and 27 are rejected under 35 U.S.C. 102(e) as being anticipated by Shang; Quanyuan et al. (US 5788778 A). Shang teaches a method (column 4, lines 23-63; column 6, lines 13-23) of removing residue from a substrate processing chamber (10; Figure 1; column 4, lines 4-15), said method (column 4, lines 23-63; column 6, lines 13-23) comprising the steps of: forming a plasma remotely (46; Figure 1; column 4, lines 40-53) with respect to said chamber (10; Figure 1; column 4, lines 4-15), said plasma including a plurality of reactive radicals;

forming a flow of said reactive radicals traversing toward said chamber (10; Figure 1; column 4, lines 4-15); forming a nonplasma (32,34; Figure 1; column 4, lines 23-31) diluent gas flow, wherein said nonplasma diluent gas flow comprises at least one of an inert gas or a reduction gas (hydrogen as reducing gas; column 5, lines 1-5); mixing said flow of said reactive radicals and said diluent gas flow at a mixing location ("T" location at 33) downstream of a location (where "57" is detailed) of forming said flow of said reactive radicals and anterior to said chamber (10; Figure 1; column 4, lines 4-15) to form a gas-radical mixture; and flowing said gas-radical mixture into said chamber (10; Figure 1; column 4, lines 4-15), as claimed by claim 22 Shang further teaches:

- i. The method (column 4, lines 23-63; column 6, lines 13-23) as recited in claim 22 wherein said flow of reactive radicals and said gas flow are established to maintain a pressure within said chamber (10; Figure 1; column 4, lines 4-15) below one torr (column 5, lines 8-13), as claimed by claim 23
- ii. The method (column 4, lines 23-63; column 6, lines 13-23) as recited in claim 22 wherein said reactive radicals comprise atoms associated with a reactive gas, with said reactive gas being selected from a group consisting of NF<sub>3</sub> (column 5, lines 8-13), dilute F<sub>2</sub>, CF<sub>4</sub>, C<sub>2</sub>F<sub>6</sub>, C<sub>3</sub>F<sub>8</sub>, SF<sub>6</sub>, and ClF<sub>3</sub>, as claimed by claim 24
- iii. The method (column 4, lines 23-63; column 6, lines 13-23) as recited in claim 22 wherein said chamber (10; Figure 1; column 4, lines 4-15) has components therein, with a subset of said radicals in said gas-radical mixture reacting with said components creating a residue (column 6, lines 13-23) and further including the step of exhausting said residue,

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with a rate at which said residue is exhausted depending upon a rate of said diluent gas

flow, as claimed by claim 27

Claim Rejections - 35 USC § 103

5. The text of those sections of Title 35, U.S. Code not included in this action can be found

in a prior Office action.

6. Claim 28 is rejected under 35 U.S.C. 103(a) as being unpatentable over Shang; Quanyuan

et al. (US 5788778 A). Shang is discussed above. Shang further teaches "user-selected flow

rates" (column 4, lines 53-63). Shang does not teach the method (column 4, lines 23-63; column

6, lines 13-23; column 6, lines 32-39) as recited in claim 22 wherein said diluent gas flow travels

at a first rate and said flow of said reactive radicals travel at a second rate with a ratio of said first

rate to said second rate being at least 2:1, as claimed by claim 28.

It would have been obvious to one of ordinary skill in the art at the time the invention was made

to optimize the relative flow rates of Shang's gas sources.

Motivation to optimize the relative flow rates of Shang's gas sources is for "achieve optimum of

performance for a particual system as taught by Shang (column 6, lines 32-39). It would be

obvious to those of ordinary skill in the art to optimize the operation of the claimed invention (In

re Boesch, 617 F.2d 272, 205 USPQ 215 (CCPA 1980); In re Hoeschele, 406 F.2d 1403, 160

USPQ 809 (CCPA 1969); Merck & Co. Inc. v. Biocraft Laboratories Inc., 874 F.2d 804, 10

USPQ2d 1843 (Fed. Cir.), cert. denied, 493 U.S. 975 (1989); In re Kulling, 897 F.2d 1147, 14

USPQ2d 1056 (Fed. Cir. 1990), MPEP 2144.05).

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Response to Arguments

7. Applicant's arguments filed June 28, 2007 have been fully considered but they are not

persuasive.

8. Applicant states:

"

Shang thus teaches that a diluent gas, or a "minor carrier gas" using Shang's lexicography, is

mixed with reactive radicals at a location where the reactive radicals are formed. Claim 22,

however, requires that this mixing of a diluent gas and reactive radicals occurs downstream from

where the reactive radicals are formed. Furthermore, FIG. 1 at 52 and 53 in Shang clearly shows

that this cited reference teaches that a mixing of a diluent gas and reactive radicals occurs at a

location where the flow of said reactive radicals is formed, not downstream of the reactive

radical formation location as claimed in claim 22. Therefore, Shang does not teach all the

elements of claim 22 as amended and thus this cited reference does not anticipate independent

claim 22 or the dependent claims 23, 24, 27, and 28 for the same reasons

"

In reposnse, it is well established that claim terms are issued their "plain meaning" according to

MPEP 2111.01: Claim terms are presumed to have the ordinary and customary meanings

attributed to them by those of ordinary skill in the art. Sunrace Roots Enter. Co. v. SRAM Corp.,

336 F.3d 1298, 1302, 67 USPQ2d 1438, 1441 (Fed. Cir. 2003); Brookhill-Wilk 1, LLC v.

Intuitive Surgical, Inc., 334 F.3d 1294, 1298 67 USPQ2d 1132, 1136 (Fed. Cir. 2003).

Applicant's specification definition cannot be read into the claims. Specifically, that Shang forms

a nonplasma (32,34; Figure 1; column 4, lines 23-31) diluent gas flow is evident from the two

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gases (32; "Gas" x 2; Figure 1) of Shang that from the claimed diluent gas flow. Applicant appears to believe that the plasma and non-plasma gas of Shang are mixed at "remote activation chamber 46". This is completely wrong. *As claimed*, Shang clearly shows forming a plasma remotely (46; Figure 1; column 4, lines 40-53) with respect to Shang's chamber (10; Figure 1; column 4, lines 4-15), Shang's plasma including a plurality of reactive radicals (as is required in all plasmas); forming a flow (in 57) of Shang's reactive radicals traversing toward Shang's chamber (10; Figure 1; column 4, lines 4-15); forming a nonplasma (32,34; Figure 1; column 4, lines 23-31) diluent gas flow, wherein Shang's nonplasma diluent gas flow comprises at least one of an inert gas or a reduction gas (hydrogen as reducing gas; column 5, lines 1-5); mixing Shang's flow of said reactive radicals and Shang's diluent gas flow at a mixing location ("T" location at 33) downstream of a location (where "57" is detailed) of forming Shang's flow of said reactive radicals and anterior to Shang's chamber (10; Figure 1; column 4, lines 4-15) to form a gas-radical mixture, as claimed by amended claim 22.

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# Conclusion

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Examiner Rudy Zervigon whose telephone number is (571) 272-1442. The examiner can normally be reached on a Monday through Thursday schedule from 8am through 7pm. The official fax phone number for the 1763 art unit is (571) 273-8300. Any Inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Chemical and Materials Engineering art unit receptionist at (571) 272-1700. If the examiner can not be reached please contact the examiner's supervisor, Parviz Hassanzadeh, at (571) 272-1435.